


<b>Search Notes</b>  	<b>Application/Control No.</b>  10589729	<b>Applicant(s)/Patent Under Reexamination</b>  OHTSUKI ET AL.
	<b>Examiner</b>  Michael Mapa	<b>Art Unit</b>  4113

SEARCHED			
Class	Subclass	Date	Examiner
455	564	08/25/08	/MM/
	550.1, 566	02/11/09	/MM/

SEARCH NOTES			
Search Notes		Date	Examiner
INVENTOR SEARCH		8/25/08	/MM/
EAST SEARCH		8/25/08	/MM/
UPDATED EAST SEARCH		02/11/09	/MM/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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